

8228 SYSTEM CONTROLLER AND BUS DRIVER FOR 8080A CPU

- Single Chip System Control for MCS®-80 Systems
- Built-In Bidirectional Bus Driver for Data Bus Isolation
- Allows the Use of Multiple Byte Instructions (e.g. CALL) for Interrupt Acknowledge
- Reduces System Package Count

- User Selected Single Level Interrupt Vector (RST 7)
- Available in EXPRESS— Standard Temperature Range
- Available in 28-Lead Cerdip and Plastic Packages

(See Packaging Spec, Order #231369)

The Intel 8228 is a single chip system controller and bus driver for MCS®-80. It generates all signals required to directly interface MCS-80 family RAM, ROM, and I/O components.

A bidirectional bus driver is included to provide high system TTL fan-out. It also provides isolation of the 8080 data bus from memory and I/O. This allows for the optimization of control signals, enabling the systems designer to use slower memory and I/O. The isolation of the bus driver also provides for enhanced system noise immunity.

A user selected single level interrupt vector (RST 7) is provided to simplify real time, interrupt driven, small system requirements. The 8228 also generates the correct control signals to allow the use of multiple byte instructions (e.g., CALL) in response to an interrupt acknowledge by the 8080A. This feature permits large, interrupt driven systems to have an unlimited number of interrupt levels.

The 8228 is designed to support a wide variety of system bus structures and also reduce system package count for cost effective, reliable design of MCS-80 systems.

NOTE:

The specifications for the 3228 are identical with those for the 8228.

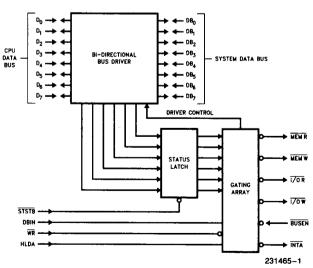


Figure 1. Block Diagram



D7-DO	Data Bus (8080 Side)
DB7-DB0	Data Bus (System Side)
I/OR	I/O Read
I/ŌW	I/O Write
MEMA	Memory Read
MEMM	Memory Write
DBIN	DBIN (from 8080)

INTA	Interrupt Acknowledge
HLDA	HLDA (from 8080)
WR	WR (from 8080)
BUSEN	Bus Enable Input
डाडाह	Status Strobe (from 8224)
Vcc	+ 5V
GND	0 Volts

Figure 2. Pin Configuration



ABSOLUTE MAXIMUM RATINGS*

Temperature Under Bias	0°C to +70°C
Storage Temperature	65°C to +150°C
Supply Voltage, V _{CC}	0.5V to +7V
Input Voltage	- 1.5 to + 7V
Output Current	100 mA

NOTICE: This is a production data sheet. The specifications are subject to change without notice.

*WARNING: Stressing the device beyond the "Absolute Maximum Ratings" may cause permanent damage. These are stress ratings only. Operation beyond the "Operating Conditions" is not recommended and extended exposure beyond the "Operating Conditions" may affect device reliability.

D.C. CHARACTERISTICS $T_A = 0$ °C to +70°C, $V_{CC} = 5V \pm 5\%$

Symbol	Parameter		Limits					
			Min	Typ(1)	Max	Unit	Test Conditions	
V _C	Input Clamp Voltage, All Input			0.75	-1.0	٧	$V_{CC} = 4.75V; I_{C} = -5 \text{ mA}$	
lF	Input Load Current	STSTB			500	μΑ	V _{CC} = 5.25V	
		D ₂ & D ₆			750	μΑ	V _F = 0.45V	
		D ₀ , D ₁ , D ₄ , D ₅ & D ₇			250	μА		
		All Other Inputs			250	μΑ		
I _R Input L	Input Leakage Current	STSTB			100	μΑ	V _{CC} = 5.25V	
		DB ₀ -DB ₇			20	μΑ	V _R = 5.25V	
		All Other Inputs			100	μΑ		
V _{TH}	Input Threshold Voltage, All Inputs		0.8		2.0	٧	V _{CC} = 5V	
Icc	Power Supply Current			140	190	mA	V _{CC} = 5.25V	
V _{OL}	Output Low Voltage	D ₀ -D ₇			0.45	٧	$V_{CC} = 4.75V; I_{OL} = 2 \text{ mA}$	
		All Other Outputs			0.45	٧	I _{OL} = 10 mA	
V _{OH}	Output High Voltage	D ₀ -D ₇	3.6	3.8		٧	$V_{CC} = 4.75V; I_{OH} = -10\mu A$	
İ		All Other Outputs	2.4			٧	$I_{OH} = -1 \text{ mA}$	
los	Short Circuit Current, All Outputs		15		90	mA	V _{CC} = 5V	
IO (off) Off State Output Current		nt			100	μΑ	$V_{CC} = 5.25V; V_{O} = 5.25V$	
	All Control Outputs				- 100	μΑ	$V_{O} = 0.45V$	
INT	INTA Current				5	mA	(See INTA Test Circuit)	

NOTE:

^{1.} Typical values are for $T_A = 25^{\circ}C$ and nominal supply voltages.



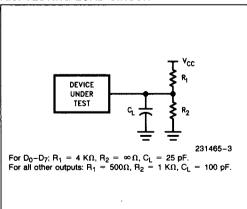
CAPACITANCE $V_{BIAS}=2.5V, V_{CC}=5.0V, T_A=25^{\circ}C, f=1$ MHz 1. This parameter is periodically sampled and not 100% tested.

Cumbal	Parameter		11-14		
Symbol		Min	Typ(1)	Max	Unit
C _{IN}	Input Capacitance		8	12	рF
C _{OUT}	Output Capacitance Control Signals		7	15	pF
1/0	I/O Capacitance (D or DB)		8	15	pF

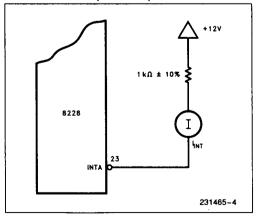
A.C. CHARACTERISTICS $T_A = 0^{\circ}C$ to $+70^{\circ}C$, $V_{CC} = 5V \pm 5\%$

Symbol	Perameter	Limits		11-14	Conditions	
	Parameter		Max	Unit	Conditions	
tpw	Width of Status Strobe	22		ns		
tss	Setup Time, Status Inputs D ₀ -D ₇	8		ns		
tsH	Hold Time, Status Inputs D ₀ -D ₇	5		ns		
t _{DC}	Delay from STSTB to any Control Signal	20	60	ns	C _L = 100 pF	
t _{RR}	Delay from DBIN to Control Outputs		30	ns	C _L = 100 pF	
t _{RE}	Delay from DBIN to Enable/Disable 8080 Bus		45	ns	$C_L = 25 pF$	
t _{RD}	Delay from System Bus to 8080 Bus during Read		30	ns	C _L = 25 pF	
twR	Delay from WR to Control Outputs	5	45	ns	C _L = 100 pF	
twe	Delay to Enable System Bus DB ₀ -DB ₇ after STSTB		30	ns	C _L = 100 pF	
t _{WD}	Delay from 8080 Bus D ₀ -D ₇ to System Bus DB ₀ -DB ₇ during Write	5	40	ns	C _L = 100 pF	
tE	Delay from System Bus Enable to System Bus DB ₀ -DB ₇		30	ns	$C_{L} = 100 pF$	
t _{HD}	HLDA to Read Status Outputs		25	ns		
tos	Setup Time, System Bus Inputs to HLDA	10		ns		
t _{DH}	Hold Time, System Bus Inputs to HLDA	20		ns	C _L = 100 pF	

A.C. TESTING LOAD CIRCUIT

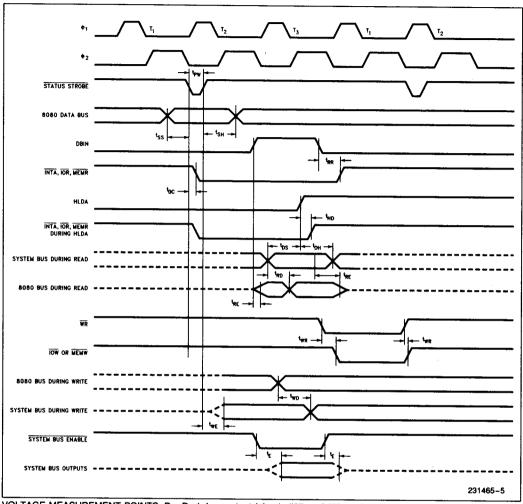


INTA Test Circuit (for RST 7)





WAVEFORMS



VOLTAGE MEASUREMENT POINTS: D₀-D₇ (when outputs) Logic "0" = 0.8V, Logic "1" = 3.0V. All other signals measured at 1.5V.